

## Photograph No.1 Setup for output power, occupied bandwidth, emission mask and conducted spurious emission measurements





Photograph No.2 Setup for spurious emission measurements in the anechoic chamber below 30 MHz



Photograph No.3 Setup for radiated emission measurements in the anechoic chamber from 30 to 1000 MHz



Photograph No.4 Setup for radiated emission measurements in the anechoic chamber above 1000 MHz



Photograph No.5 Setup for spurious emission measurements at the OATS above 1000 MHz

## Photograph No.6 Setup for spurious emission measurements at the OATS above 1000 MHz, EUT close view





Photograph No.7 Setup for substitution ERP measurements of spurious at the OATS above 1000 MHz



## Photograph No.8 Setup for frequency stability measurements



## Photograph No.9 Setup for conducted emission measurements on the power lines